Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10583507	CHEN ET AL.
Examiner	Art Unit
Benny Lee	2817

SEARCHED					
Class	Subclass	Date	Examiner		
333	26	4 March 2009	BTL		
333	34, 21A	6 March 2009	BTL		

SEARCH NOTES		
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